

Search Notes

Application/Control No.

10/623,026

Examiner

Tuan V. Thai

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2186

SEARCHED

Class	Subclass	Date	Examiner
711	5	7/19/2006	TH
711	100	7/19/2006	TH
711	154	7/19/2006	TH
711	170	7/19/2006	TH
711	200	7/19/2006	TH
370	395.7	7/19/2006	TH
370	412	7/19/2006	TH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
711	5	7/19/2006	TH
370	395.7	7/19/2006	TH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IEEE updated search; NPL search; EAST updated searches: IBMTDB DERWENTS EPO/JPO abstract USPGPUB NORHT database	7/19/2006	TH